Notice of References Cited

Application/Control No.

10/027,919

Examiner Edna Wong Applicant(s)/Patent Under Reexamination SEITA ET AL.

Art Unit 1753

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,674,660	07-1972	Lyde, Derek Martin	205/295
	В	US-4,469,564	09-1984	Okinaka et al.	205/125
	С	US-6,649,038	11-2003	Mikkola et al.	205/143
	D	US-2002/0043468	04-2002	Mikkola et al.	205/157
	E	US-		/	
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No 10/027,919 Examiner Edna Wong U.S. PATENT DOCUMENTS * Document Number Country Code-Number-Kind Code MM-YYYYY A US-5,252,196 Application/Control No Applicant(s)/Patent Under Reexamination SEITA-ET AL. Page 1 of 1 Classification A US-5,252,196 10-1993 Sonnenberg et al. 205/296

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,252,196	10-1993	Sonnenberg et al.	205/296
	В	US-4,009,087	02-1977	Kardos et al.	204/52R
	С	US-			
	D,	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Application/Control No. 10/027,919 Examiner Edna Wong Applicant(s)/Patent Under Reexamination SEITA ET AL. Art Unit 1753 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,384,930	05-1983	Eckles, William E.	205/253
	В	US-4,469,564	09-1984	Okinaka et al.	205/125
	O	US-6,355,153	03-2002	Uzoh et al.	205/87
	۵	US-			·
	Е	US-			
	F	US-			
	G	US-			
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	1	US-			
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	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Cade-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2264717 A	09-1993	United Kingdom	JACOBS, LOUW	C25D 03/38
	0					
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	Т					

NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.